

Search Notes

Application/Control No.

10/694,132

Examiner

John K. Ford

Applicant(s)/Patent under
Reexamination

ICHISHI ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
as	above	1/57	JF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR